

<b>Notice of References Cited</b>		Application/Control No. 09/843,573	Applicant(s)/Patent Under Reexamination DEMLER ET AL.	
		Examiner Thomas H. Stevens	Art Unit 2123	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
*	U	Lewis et al., "A Prototype Unit for Built-In Self-Test of Analog Circuits" IEEE March 1999. pg. 221-224		
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.